Characterization of low-density HEDP laser target foam components using monochromatic soft x-ray sources

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May 22, 2012





We require accurate characterization of low-density foam components for successful radiation flow experiments on NIF and Omega

- Small deviations in foam density dramatically impact radiation propagation and complicate assessment of flow models
- Foam density is currently characterized in bulk and assumed to stay unchanged during machining
- Individual components are too light to weigh, thus normally do not make density measurements of single parts
- For this reason we constructed a monochromatic x-ray imager to measure the x-ray transmission of single component foams, used to derive a line-averaged density
- For best results, this measurement should be performed in conjunction with ICP-MS (inductively coupled plasma mass spectrometry) analysis, to constrain impurity levels
- Depending on the size and density of the part in question, the density measurement uncertainty can reach the limiting factor of the cold opacity uncertainty, ~ 1%

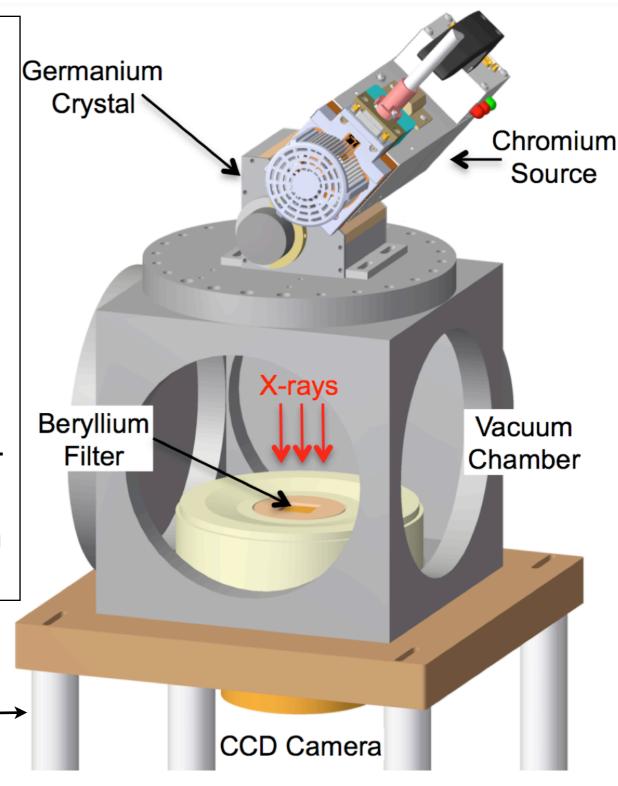




We measure the transmission of soft x-rays through lowdensity foam components

- The x-ray imager consists of a soft x-ray generating device at either 2.3 or 5.4 keV, each with a dedicated sample chamber and CCD camera
- Recently re-configured to use contact radiography: X-rays are transmitted through the sample and imaged onto a CCD at ~1× magnification, recording line-averaged transmission as a function of position
- The soft x-rays are in the right regime to measure very small density variations in lowdensity C₈H₈ and SiO₂ foam targets
- We can measure line-averaged transmission to within ~ 1% relative uncertainty

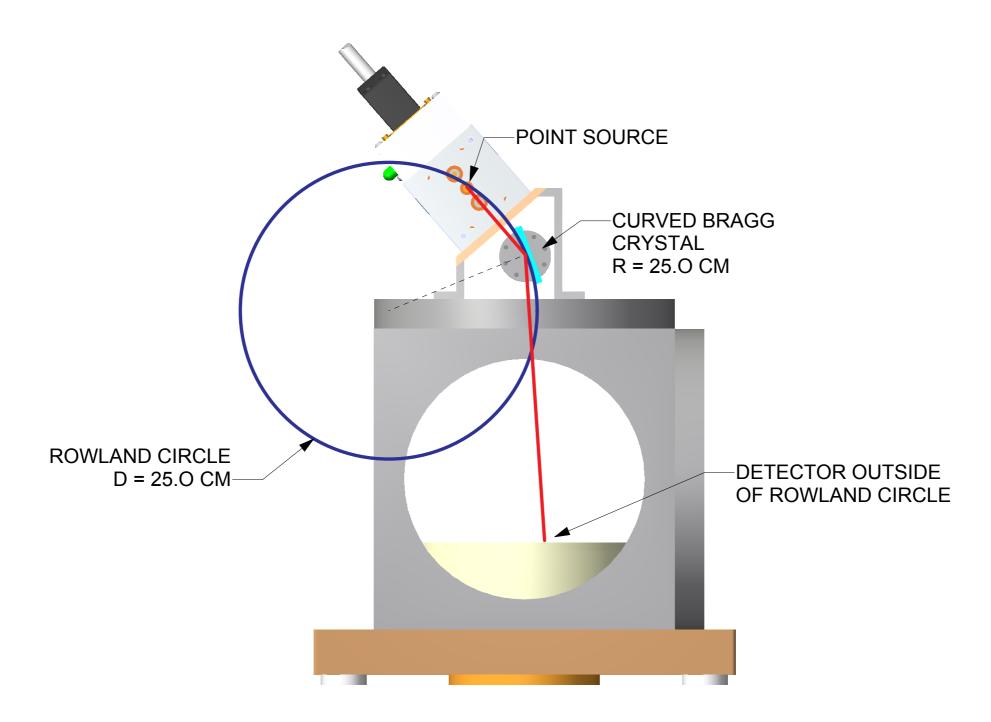
Chromium K α (5.4 keV) setup







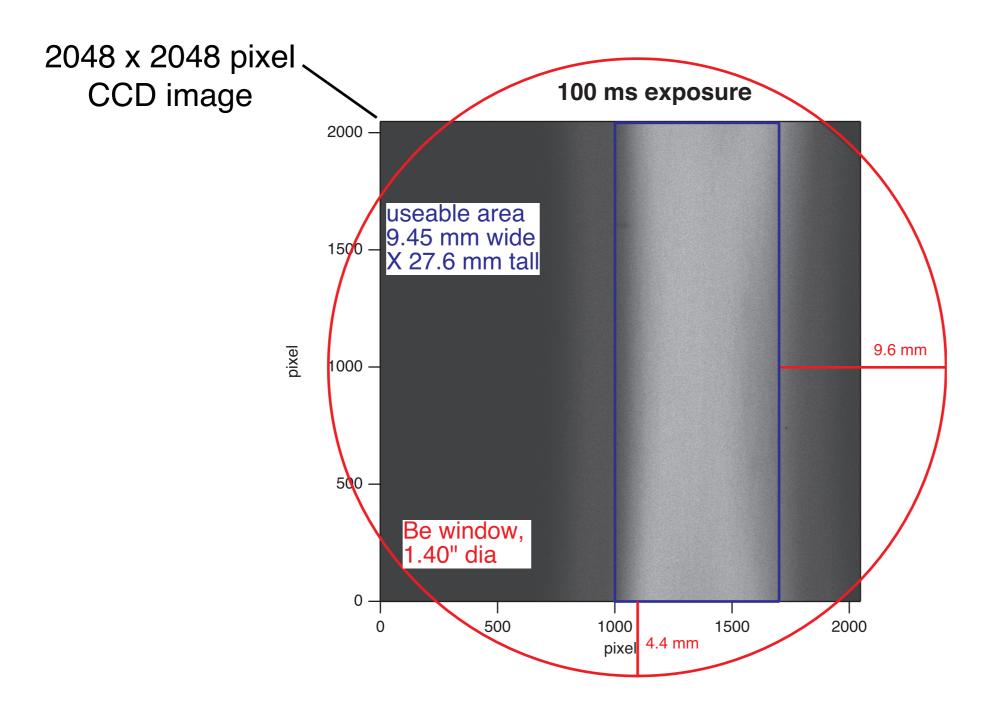
We illuminate a larger area of the detector by locating it outside the Rowland circle







The x-ray beam covers enough area on the detector to allow characterization of most HEDP target foams







With knowledge of cold opacity, high resolution monochromatic transmission measurements constrain line-averaged density

Change in intensity as light passes through an absorptive medium

opacity intensity
$$dI(v,z) = -k(v)\rho(z)I(v,z)dz$$

$$\uparrow \qquad \uparrow$$
density distance

Solving for intensity and integrating over path length

$$\int \frac{dI(v,z)}{I(v,z)} = -\int k(v)\rho(z)dz$$

$$\ln I(v,z) - \ln I_0(v,z) \qquad \text{density}$$

$$= -\int k(v)\rho(z)dz = -k(v)\overline{\rho}\int dz = -k(v)\overline{\rho}z$$
thus
$$I(v,z) = I_0(v,z)e^{-k(v)\overline{\rho}z} \text{(general formula)}$$

We use a Dirac delta function for the monochromatic source and integrate over *v*

$$\int I(v,z)\delta(v-v_0)dv = \int I_0(v,z)e^{-k(v)\bar{\rho}z}\delta(v-v_0)dv$$
 or mono-energetic cold opacity
$$I(v_0,z) = I_0(v_0,z)e^{-k(v_0)\bar{\rho}z}$$

And then solve for the line-averaged density

$$-\ln\frac{I(v_0,z)}{I_0(v_0,z)} = -\ln T(v_0,z) = k(v_0)\overline{\rho}z \quad \therefore \quad \overline{\rho} = -\frac{\ln T(v_0,z)}{k(v_0)z}$$





Taking partial derivatives obtain error terms for T, k, z

Line-averaged density

$$\overline{\rho} = -\frac{\ln T(v_0, z)}{k(v_0)z}$$

Take partial derivative to obtain each error term

$$\begin{split} \partial \overline{\rho} &= \left| \frac{\partial \overline{\rho}}{\partial T} \right| \partial T + \left| \frac{\partial \overline{\rho}}{\partial k} \right| \partial k + \left| \frac{\partial \overline{\rho}}{\partial z} \right| \partial z \\ &= \left| \frac{1}{T \left(v_0, z \right) k \left(v_0 \right) z} \right| \partial T + \left| \frac{\ln T \left(v_0, z \right)}{k \left(v_0 \right)^2 z} \right| \partial k + \left| \frac{\ln T \left(v_0, z \right)}{k \left(v_0 \right) z^2} \right| \partial z \end{split}$$
 Transmission Opacity Axial Distance error term error term

For opacity and axial distance we can assume the following uncertainties:

Cold opacity
$$\rightarrow \frac{\partial k}{k(v_0)} = 1\%$$
 and Distance $\rightarrow \partial z = 1 \mu \text{m}$



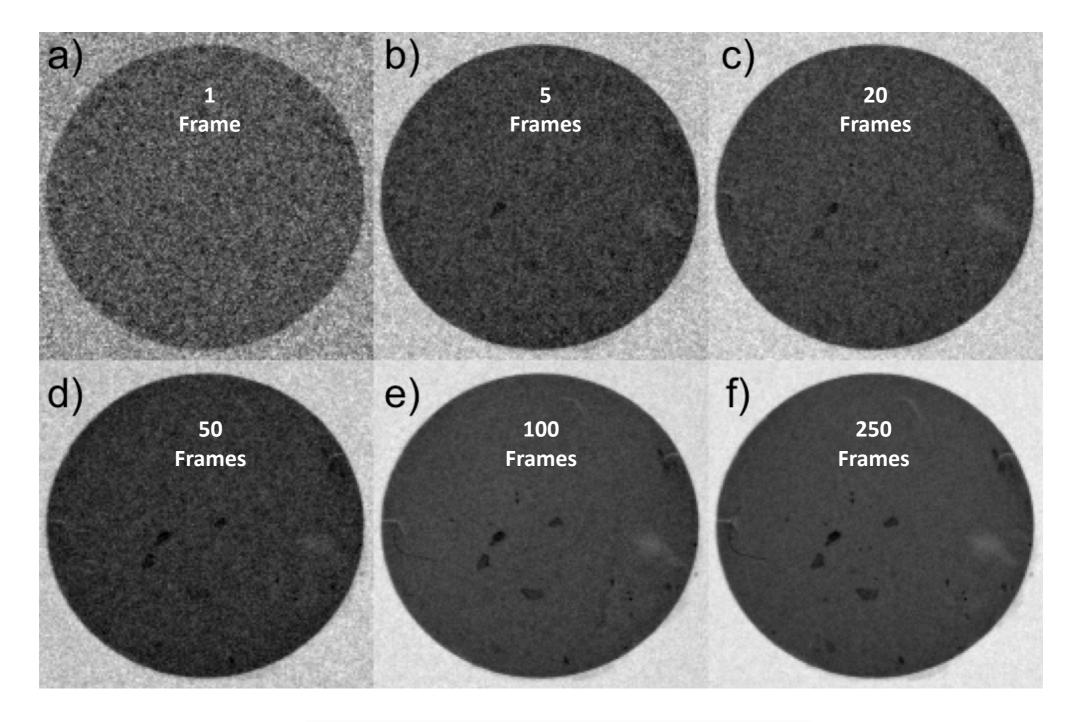


The experimental error in the x-ray transmission measurement is dominated by photon statistics

Sample Specifications

 SiO_2 $\rho \sim 125$ mg/cc $h = 200 \, \mu m$ $d = 2000 \, \mu m$

 $m \sim 78 \mu g$



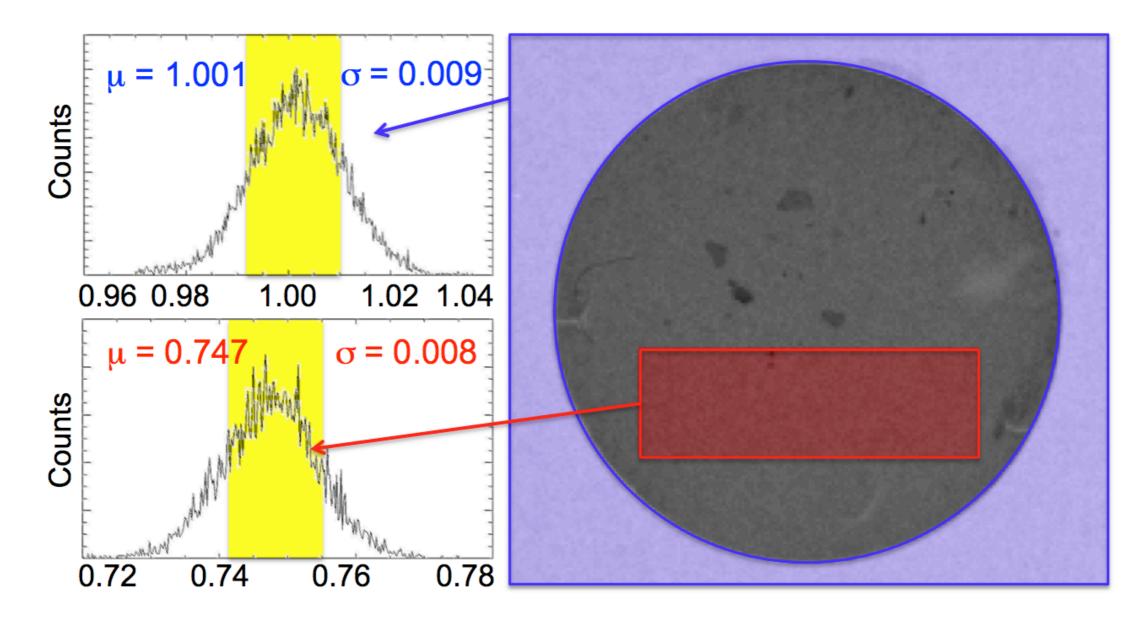


All subsequent results are extracted from 250 accumulated images



The pixel-to-pixel uncertainty is ~ 1%, greater reductions are achieved by averaging over larger regions of interest

Pixel-to-pixel variation for 250 frame ensemble





A 75- μ m by 75- μ m region of interest yields a $\sigma_T \sim 0.2\%$



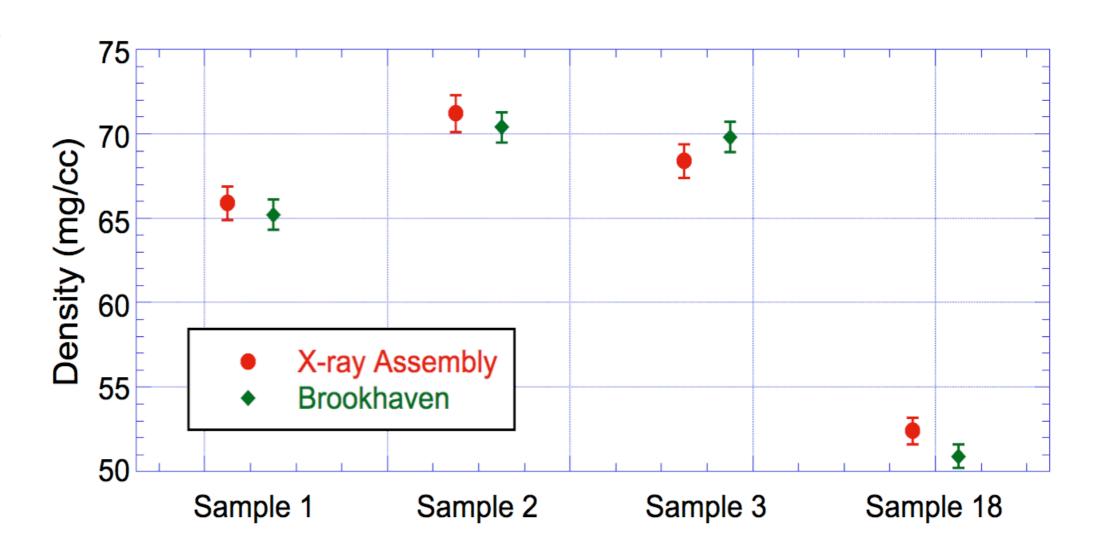
Densities inferred with our x-ray assembly are statistically equivalent to measurements made at Brookhaven's NSLS

	X-ray Assembly	NSLS	~ 15 µm Silicon
Transmission @ 5.415 keV	59.4 ± 0.8 %	59.0 ± 0.5 %	Standard

Sample Specifications

 SiO_2 $\rho \sim 70 \text{ mg/cc}$ $h = 200 \,\mu\text{m}$ $d = 400 \,\mu\text{m}$

 $m \sim 2 \mu g$







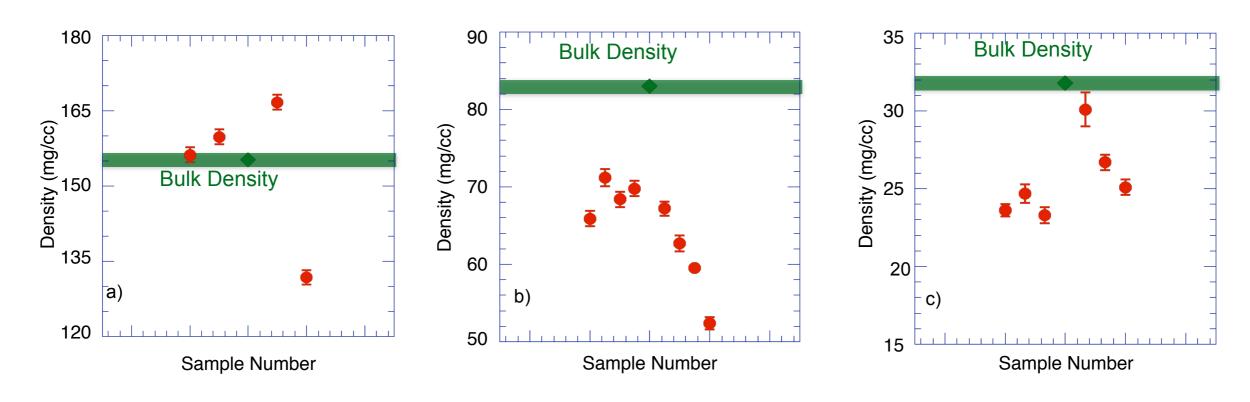
A blind study provided the best option to challenge our foam manufacture and characterization techniques

- Multiple SiO₂ samples at three desired densities were manufactured
- Each sample was 200 microns thick with a 400 micron diameter
- Densities would range between 10-160 mg/cc and were cast in place
- Since overall part mass was too small for gravimetric measurements, bulk witness samples were manufactured and characterized
- Samples were also characterized on the x-ray DCS
- A subset of samples would also be characterized at Brookhaven National Laboratory's NSLS





Blind study results show the bulk density often differs significantly from individual samples



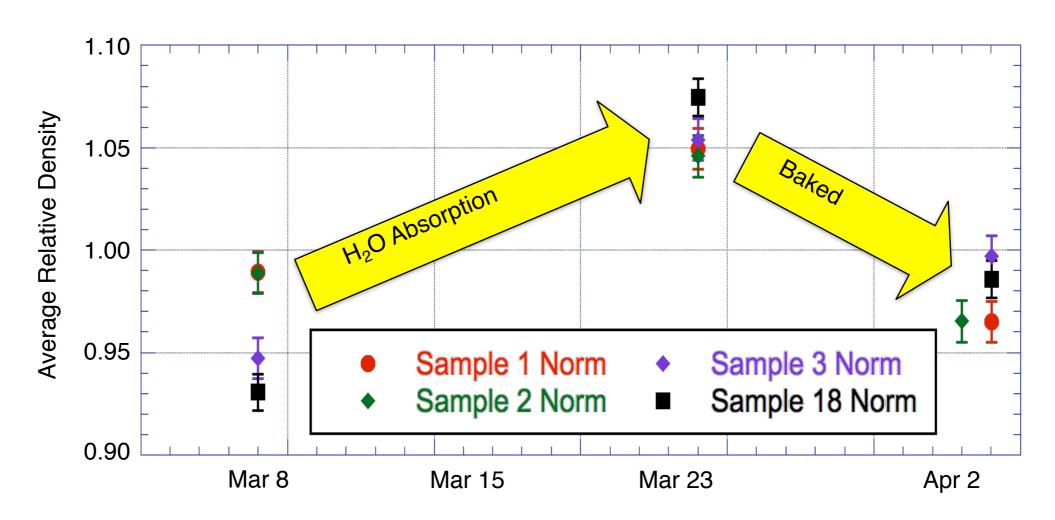
- Bulk density measurements for witness samples disagree with that derived from x-ray transmission for small cast in place SiO₂ foams
- Significant variability existed between samples of supposedly identical density
- The x-ray DCS clearly resolves this variability





Increased water content can lead to higher inferred densities if not properly accounted for

X-ray assembly data showing the hygroscopic nature of SiO₂ foams



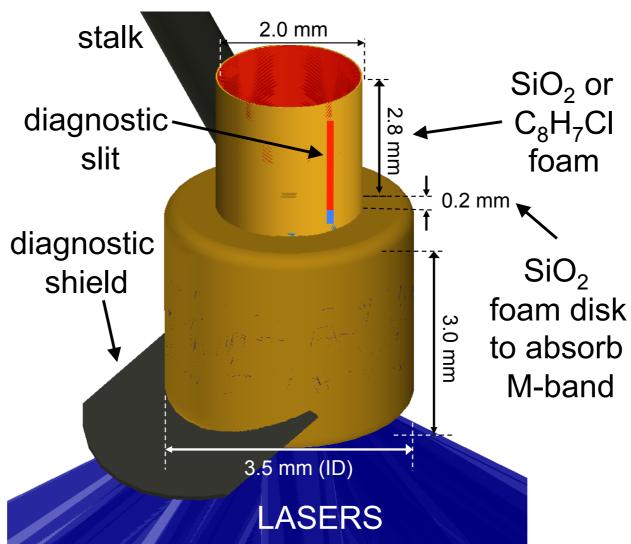
After baking, the densities approach their original values.





Foam density characterization station is already impacting selection of NIF HEDP targets

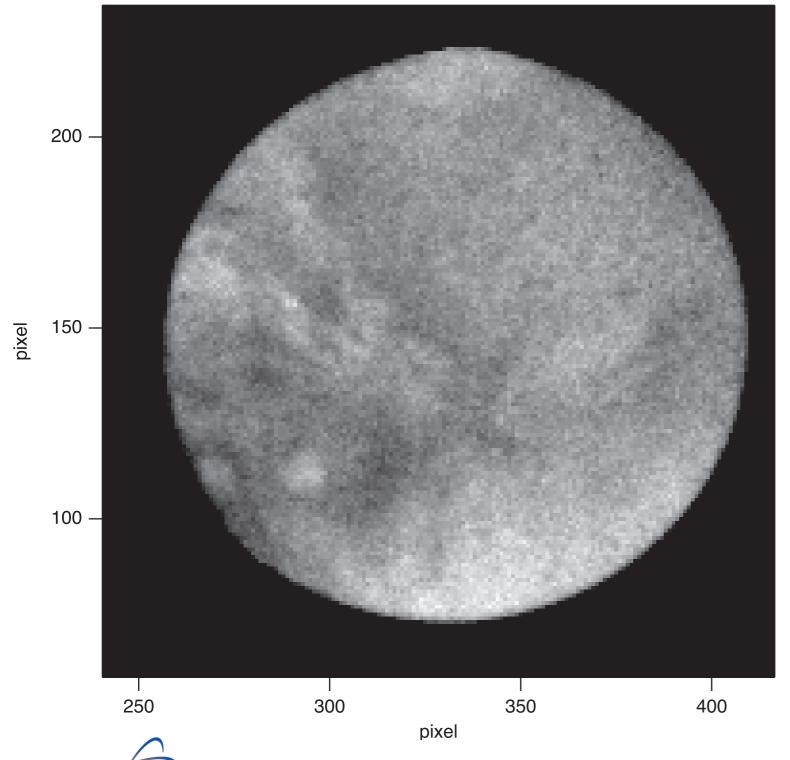
- Our x-ray assembly is impacting the first set of non-ignition related experiments being performed at NIF in support of development and validation of models used in our codes
- HEDP targets include 125 mg/cc silica aerogel or chlorinated plastic foams that require detailed characterization

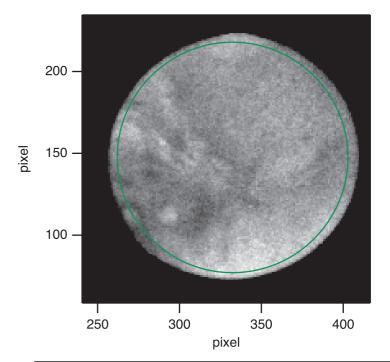






Some targets, such as this HiPE (C₈H₇CI) one - were eliminated from our shot sequence after characterization





Averaging over ROI: $\rho_{\text{avg}} = 124.0 \pm 1.3 \text{ mg/cm}^3$ ($\rho_{\text{witness}} = 126 \text{ mg/cm}^3$)

Assumptions:

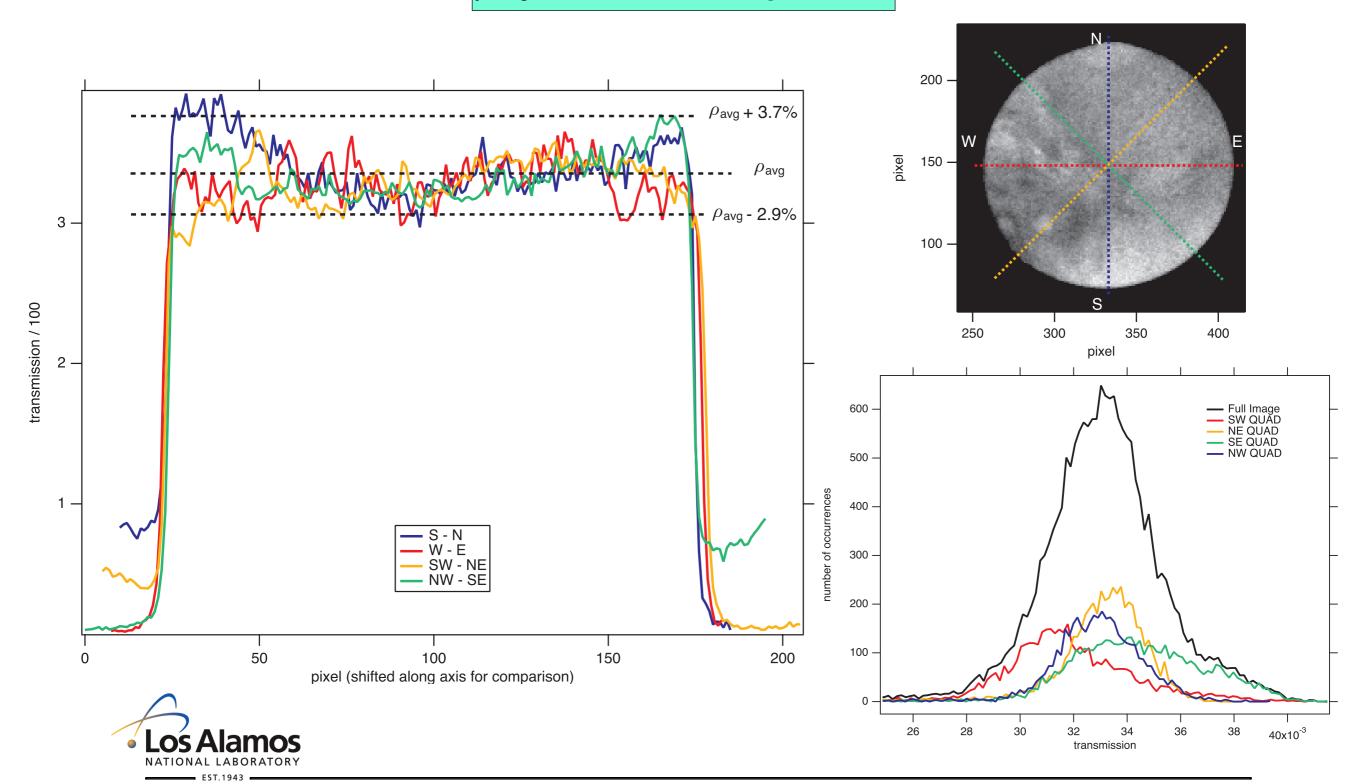
HiPE cold opacity @5415 eV = $90.3 \text{ cm}^2/\text{g} \pm 1\%$

thickness error is \pm 1 μ m



The x-ray assembly also provides a good test of density uniformity

 $\rho_{\text{avg}} = 124.0 \pm 1.3 \text{ mg/cm}^3$



Summary

- We have constructed a monochromatic x-ray imager to quantify the density of low-mass single component foams
- Density inferences from the x-ray assembly are identical to those obtained at NSLS
- Small cast-in-place SiO₂ foams often exhibit high variability in their density, and are poorly represented by bulk measurements on witness samples
- For the masses and sizes tested, the x-ray assembly resolved lineaverage transmission down to ~1%
- When left exposed to air, the SiO₂ samples absorbed water, leading to an increase in inferred densities
 - easily resolved by the x-ray DCS
 - more characterization of this effect is essential to assure foam components at the time of experiments are understood
- Current efforts implementing 2.3 and 8.0 keV sources are underway



